

SIGC42T120CS

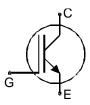
IGBT Chip in NPT-technology

FEATURES:

- 1200V NPT technology
- 180µm chip
- low turn-off losses
- short tail current
- positive temperature coefficient
- easy paralleling

This chip is used for:

- SGW25N120
- Applications:
- drives, SMPS, resonant applications



Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code
SIGC42T120CS	1200V	25A	6.59 x 6.49 mm ²	sawn on foil	Q67050- A4048-A001

MECHANICAL PARAMETER:

Raster size	6.59 x 6.49	mm ²	
Emitter pad size	2 x (2.18 x 1.58)		
Gate pad size	1.06 x 0.65		
Area total / active	42.8 / 33.5		
Thickness	180	μm	
Wafer size	150	mm	
Flat position	180	grd	
Max.possible chips per wafer	334 pcs		
Passivation frontside	Photoimide		
Emitter metallization	3200 nm Al Si 1%		
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding		
Die bond	electrically conductive glue or solder		
Wire bond	Al, <500µm		
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm		
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C		



SIGC42T120CS

MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T _j =25 °C	V _{CE}	1200	V
DC collector current, limited by T _{jmax}	I _C	1)	А
Pulsed collector current, t _p limited by T _{jmax}	I _{cpuls}	75	А
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T _j , T _{stg}	-55 +150	°C

1) depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_j =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
	Cymbol	Conditions	min.	typ.	max.	U
Collector-emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0V , I _C = 1.5mA	1200			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =25A	2.5	3.0	3.6	V
Gate-emitter threshold voltage	V _{GE(th)}	$I_C=1mA$, $V_{GE}=V_{CE}$	3.0	4.0	5.0	
Zero gate voltage collector current	I _{CES}	V_{CE} =1200V , V_{GE} =0V			3	μA
Gate-emitter leakage current	I _{GES}	V_{CE} =0V , V_{GE} =20V			120	nA

ELECTRICAL CHARACTERISTICS (tested at component):

Parameter	Symbol Conditions	Value			Unit	
Falameter	Symbol	Conditions	min.	typ.	max.	Unit
Input capacitance	Ciss	V _{CE} =25V,	-	2150	2600	pF
Output capacitance	Coss	$V_{GE}=0V$,	-	160	190	
Reverse transfer capacitance	Crss	f=1MHz	-	110	130	

SWITCHING CHARACTERISTICS (tested at component), Inductive Load

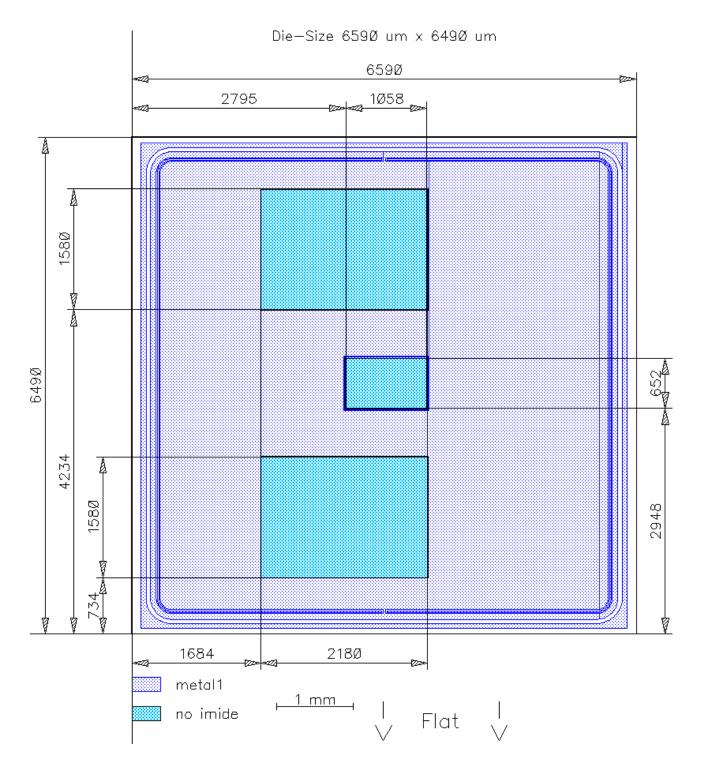
Parameter	Symbol	Conditions ¹⁾	Value			Unit
			min.	typ.	max.	Onit
Turn-on delay time	t _{d(on)}	$T_{\rm j}$ = 150 ° C	I	50	60	ns
Rise time	t _r	$V_{\rm CC} = 800 V$,	-	36	43	
Turn-off delay time	$t_{d(off)}$	I _C =25A, V _{GE} =-15/15V,	-	820	990	
Fall time	t _f	R _G = 22Ω	-	42	50	

¹⁾ values also influenced by parasitic L- and C- in measurement and package.



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CHIP DRAWING:





FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet	SGW25N120
DESCRIPTION:	

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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